Preferred Devices

JFET Switching Transistors

N-Channel - Depletion

Features

• Pb-Free Packages are Available*

MAXIMUM RATINGS

Rating	Symbol	Value	Unit
Drain-Source Voltage	V _{DS}	30	Vdc
Drain-Gate Voltag	V_{DG}	30	Vdc
Gate-Source Voltage	V_{GS}	30	Vdc
Forward Gate Current	$I_{G(f)}$	50	mAdc
Total Device Dissipation @ T _A = 25°C Derate above 25°C	P _D	350 2.8	mW mW/°C
Operating and Storage Channel Temperature Range	T _{channel} , T _{stg}	-65 to +150	°C

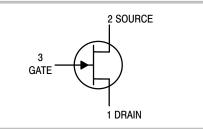
Maximum ratings are those values beyond which device damage can occur. Maximum ratings applied to the device are individual stress limit values (not normal operating conditions) and are not valid simultaneously. If these limits are exceeded, device functional operation is not implied, damage may occur and reliability may be affected.

www.DataSheel4U.com



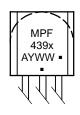
ON Semiconductor®

http://onsemi.com





MARKING DIAGRAM



MPF439x = Device Code

x = 2 or 3

A = Assembly Location

Y = Year
WW = Work Week
• Pb-Free Package

(Note: Microdot may be in either location) ORDERING INFORMATION

Device	Package	Shipping [†]
MPF4392	TO-92	1000 Units / Bulk
MPF4392G	TO-92 (Pb-Free)	1000 Units / Bulk
MPF4393	TO-92	1000 Units / Bulk
MPF4393G	TO-92 (Pb-Free)	1000 Units / Bulk
MPF4393RLRP	TO-92	1000 / Ammo Box
MPF4393RLRPG	TO-92 (Pb-Free)	1000 / Ammo Box

Preferred devices are recommended choices for future use and best overall value.

^{*}For additional information on our Pb–Free strategy and soldering details, please download the ON Semiconductor Soldering and Mounting Techniques Reference Manual, SOLDERRM/D.

ELECTRICAL CHARACTERISTICS (T_A = 25°C unless otherwise noted)

Characteristic	, mee neteu)	Symbol	Min	Tvn	Max	Unit
OFF CHARACTERISTICS		Symbol	IVIII	Тур	IVIAX	Unit
		M			1	
Gate – Source Breakdown Voltage (I _G = 1.0 μAdc, V _{DS} = 0)		V _{(BR)GSS}	30	-	-	Vdc
Gate Reverse Current $(V_{GS} = 15 \text{ Vdc}, V_{DS} = 0)$ $(V_{GS} = 15 \text{ Vdc}, V_{DS} = 0, T_A = 100^{\circ}\text{C})$		I _{GSS}	- -	- -	1.0 0.2	nAdc μAdc
$\begin{aligned} & \text{Drain-Cutoff Current} \\ & (V_{DS} = 15 \text{ Vdc}, V_{GS} = 12 \text{ Vdc}) \\ & (V_{DS} = 15 \text{ Vdc}, V_{GS} = 12 \text{ Vdc}, T_A = 100^{\circ}\text{C}) \end{aligned}$		I _{D(off)}	- -	- -	1.0 0.1	nAdc μAdc
Gate Source Voltage (V _{DS} = 15 Vdc, I _D = 10 nAdc)	MPF4392 MPF4393	V_{GS}	-2.0 -0.5	_ _	-5.0 -3.0	Vdc
ON CHARACTERISTICS						
Zero-Gate-Voltage Drain Current (Note 1) (V _{DS} = 15 Vdc, V _{GS} = 0)	MPF4392 MPF4393	I _{DSS}	25 5.0		75 30	mAdc
	MPF4392 MPF4393	V _{DS(on)}	_ _	_ _	0.4 0.4	Vdc
Static Drain–Source On Resistance (I _D = 1.0 mAdc, V _{GS} = 0)	MPF4392 MPF4393	r _{DS(on)}	_ _	_ _	60 100	Ω
SMALL-SIGNAL CHARACTERISTICS					•	
Forward Transfer Admittance $(V_{DS} = 15 \text{ Vdc}, I_D = 25 \text{ mAdc}, f = 1.0 \text{ kHz})$ $(V_{DS} = 15 \text{ Vdc}, I_D = 5.0 \text{ mAdc}, f = 1.0 \text{ kHz})$	MPF4392 MPF4393	y _{fs}	_ _	17 12		mmhos
Drain–Source "ON" Resistance $(V_{GS} = 0, I_D = 0, f = 1.0 \text{ kHz})$	MPF4392 MPF4393	r _{ds(on)}	_ _	_ _	60 100	Ω
Input Capacitance (V _{GS} = 15 Vdc, V _{DS} = 0, f = 1.0 MHz)		C _{iss}	-	6.0	10	pF
Reverse Transfer Capacitance $(V_{GS} = 12 \text{ Vdc}, V_{DS} = 0, f = 1.0 \text{ MHz})$ $(V_{DS} = 15 \text{ Vdc}, I_D = 10 \text{ mAdc}, f = 1.0 \text{ MHz})$		C _{rss}	- -	2.5 3.2	3.5 -	pF
SWITCHING CHARACTERISTICS						
Rise Time (See Figure 2) (I _{D(on)} = 6.0 mAdc) (I _{D(on)} = 3.0 mAdc)	MPF4392 MPF4393	t _r	_ _	2.0 2.5	5.0 5.0	ns
Fall Time (See Figure 4) (V _{GS(off)} = 7.0 Vdc) (V _{GS(off)} = 5.0 Vdc)	MPF4392 MPF4393	t _f	_ _	15 29	20 35	ns
Turn-On Time (See Figures 1 and 2) (I _{D(on)} = 6.0 mAdc) (I _{D(on)} = 3.0 mAdc)	MPF4392 MPF4393	t _{on}	_ _	4.0 6.5	15 15	ns
Turn-Off Time (See Figures 3 and 4) (V _{GS(off)} = 7.0 Vdc) (V _{GS(off)} = 5.0 Vdc)	MPF4392 MPF4393	t _{off}	_ _	20 37	35 55	ns

^{1.} Pulse Test: Pulse Width \leq 300 μ s, Duty Cycle \leq 3.0%.

TYPICAL SWITCHING CHARACTERISTICS

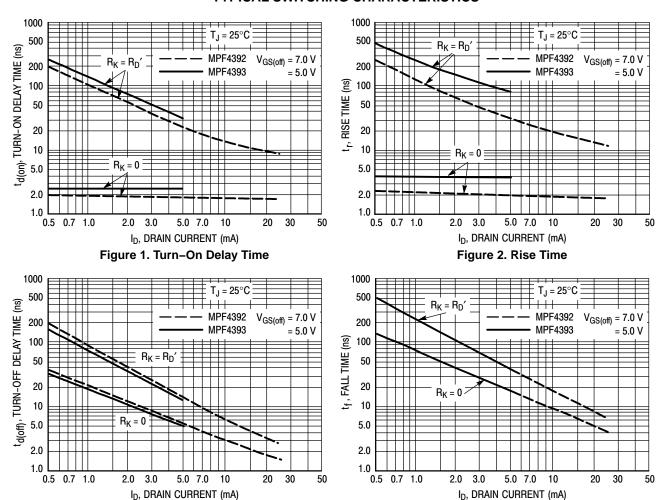


Figure 4. Fall Time

Figure 3. Turn-Off Delay Time

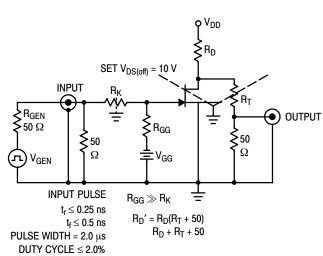


Figure 5. Switching Time Test Circuit

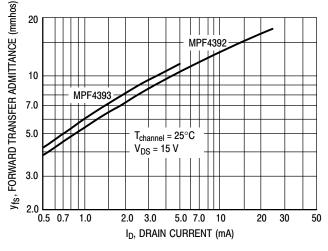


Figure 6. Typical Forward Transfer Admittance

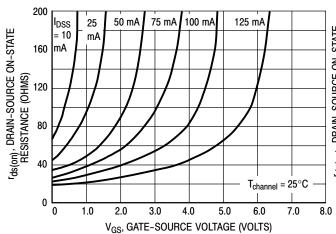


Figure 8. Effect of Gate-Source Voltage On Drain-Source Resistance

NOTE 1

The switching characteristics shown above were measured using a test circuit similar to Figure 5. At the beginning of the switching interval, the gate voltage is at Gate Supply Voltage ($-V_{GG}$). The Drain–Source Voltage (V_{DS}) is slightly lower than Drain Supply Voltage (V_{DD}) due to the voltage divider. Thus Reverse Transfer Capacitance (C_{rss}) or Gate–Drain Capacitance (C_{gd}) is charged to $V_{GG} + V_{DS}$.

During the turn–on interval, Gate–Source Capacitance (C_{gs}) discharges through the series combination of R_{Gen} and R_K . C_{gd} must discharge to $V_{DS(on)}$ through R_G and R_K in series with the parallel combination of effective load impedance (R'_D) and Drain–Source Resistance (r_{ds}) . During the turn–off, this charge flow is reversed.

Predicting turn—on time is somewhat difficult as the channel resistance r_{ds} is a function of the gate—source voltage. While C_{gs} discharges, V_{GS} approaches zero and r_{ds} decreases. Since C_{gd} discharges through r_{ds} , turn—on time is non—linear. During turn—off, the situation is reversed with r_{ds} increasing as C_{gd} charges.

The above switching curves show two impedance conditions: 1) R_K is equal to $R_{D}{}'$ which simulates the switching behavior of cascaded stages where the driving source impedance is normally the load impedance of the previous stage, and 2) $R_K=0$ (low impedance) the driving source impedance is that of the generator.

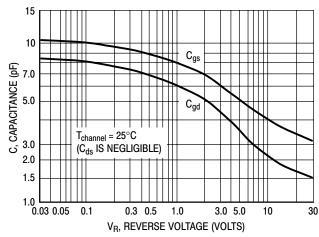


Figure 7. Typical Capacitance

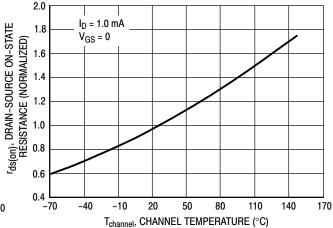


Figure 9. Effect of Temperature On Drain–Source On–State Resistance

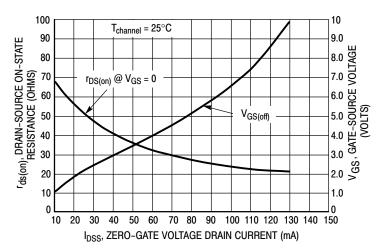


Figure 10. Effect of I_{DSS} On Drain-Source Resistance and Gate-Source Voltage

NOTE 2

The Zero–Gate–Voltage Drain Current (I_{DSS}), is the principle determinant of other J–FET characteristics. Figure 10 shows the relationship of Gate–Source Off Voltage ($V_{GS(off)}$) and Drain–Source On Resistance ($r_{ds(on)}$) to I_{DSS} . Most of the devices will be within $\pm 10\%$ of the values shown in Figure 10. This data will be useful in predicting the characteristic variations for a given part number.

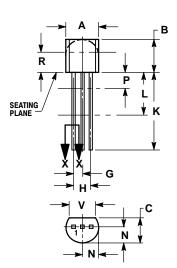
For example:

Unknown

 $r_{ds(on)}$ and V_{GS} range for an MPF4392 The electrical characteristics table indicates that an MPF4392 has an I_{DSS} range of 25 to 75 mA. Figure 10 shows $r_{ds(on)}=52~\Omega$ for $I_{DSS}=25$ mA and 30 Ω for I_{DSS} 75 mA. The corresponding V_{GS} values are 2.2 V and 4.8 V

PACKAGE DIMENSIONS

TO-92 (TO-226) CASE 29-11 **ISSUE AL**





NOTES:

- DIMENSIONING AND TOLERANCING PER ANSI Y14.5M, 1982.
- 114-3M, 1902.
 CONTROLLING DIMENSION: INCH.
 CONTOUR OF PACKAGE BEYOND DIMENSION R
 IS UNCONTROLLED.
 LEAD DIMENSION IS UNCONTROLLED IN P AND
- BEYOND DIMENSION K MINIMUM.

	INCHES		MILLIMETERS		
DIM	MIN	MAX	MIN	MAX	
Α	0.175	0.205	4.45	5.20	
В	0.170	0.210	4.32	5.33	
С	0.125	0.165	3.18	4.19	
D	0.016	0.021	0.407	0.533	
G	0.045	0.055	1.15	1.39	
Н	0.095	0.105	2.42	2.66	
J	0.015	0.020	0.39	0.50	
K	0.500		12.70		
L	0.250		6.35		
N	0.080	0.105	2.04	2.66	
P		0.100		2.54	
R	0.115		2.93		
V	0.135		3.43		

STYLE 5: PIN 1. DRAIN

- 2. SOURCE
- GATE

ON Semiconductor and un are registered trademarks of Semiconductor Components Industries, LLC (SCILLC). SCILLC reserves the right to make changes without further notice to any products herein. SCILLC makes no warranty, representation or guarantee regarding the suitability of its products for any particular purpose, nor does SCILLC assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation special, consequential or incidental damages. "Typical" parameters which may be provided in SCILLC data sheets and/or specifications can and do vary in different applications and actual performance may vary over time. All operating parameters, including "Typicals" must be validated for each customer application by customer's technical experts. SCILLC does not convey any license under its patent rights nor the rights of others. SCILLC products are not designed, intended, or authorized for use as components in systems intended for surgical implant into the body, or other applications intended to support or sustain life, or for any other application in which the failure of the SCILLC product could create a situation where personal injury or death may occur. Should Buyer purchase or use SCILLC products for any such unintended or unauthorized application, Buyer shall indemnify and hold SCILLC and its officers, employees, subsidiaries, affiliates, and distributors harmless against all claims, costs, damages, and expenses, and reasonable attorney fees arising out of, directly or indirectly, any claim of personal injury or death associated with such unintended or unauthorized use, even if such claim alleges that SCILLC was negligent regarding the design or manufacture of the part. SCILLC is an Equal Opportunity/Affirmative Action Employer. This literature is subject to all applicable copyright laws and is not for resale in any manner.

PUBLICATION ORDERING INFORMATION

LITERATURE FULFILLMENT:

Literature Distribution Center for ON Semiconductor P.O. Box 61312, Phoenix, Arizona 85082-1312 USA Phone: 480-829-7710 or 800-344-3860 Toll Free USA/Canada Fax: 480-829-7709 or 800-344-3867 Toll Free USA/Canada Email: orderlit@onsemi.com

N. American Technical Support: 800-282-9855 Toll Free

Japan: ON Semiconductor, Japan Customer Focus Center 2-9-1 Kamimeguro, Meguro-ku, Tokyo, Japan 153-0051 Phone: 81-3-5773-3850

ON Semiconductor Website: http://onsemi.com

Order Literature: http://www.onsemi.com/litorder

For additional information, please contact your local Sales Representative.